


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510487	<b>Applicant(s)/Patent Under Reexamination</b>  FURON ET AL.
	<b>Examiner</b>  SARGON N NANO	<b>Art Unit</b>  2457

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Primary Ramy Osman	3/4/2009	SN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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